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PATENT

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Docket No.: 49959-220

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Application of : Customer Number: 20277

Gilad ALMOGY, et al. : Confirmation Number: 4655

Serial No.: 09/986,137 : Group Art Unit: 2881

Filed: November 07, 2001 : Examiner: Phillip A. Johnston

For: SPOT GRID ARRAY ELECTRON IMAGING SYSTEM

INFORMATION DISCLOSURE STATEMENT

Mail Stop DD Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

Dear Sir:

In accordance with the provisions of 37 C.F.R. 1.56, 1.97 and 1.98, the attention of the Patent and Trademark Office is hereby directed to the documents listed on the attached form PTO-1449. It is respectfully requested that the documents be expressly considered during the prosecution of this application, and that the documents be made of record therein and appear among the "References Cited" on any patent to issue therefrom.

This Information Disclosure Statement is being filed more than three months after the U.S. filing date AND after the mailing date of the first Office Action on the merits, but before the mailing date of a Final Rejection or Notice of Allowance.

In accordance with 37 CFR 1.17(p), please charge the fee of \$180.00 to Deposit Account No. 500417.

10/28/2003 TLUU11 00000018 500417 09986137

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The relevance of each non-English language reference, if any, is discussed in the present specification.

Please charge any shortage in fees due in connection with the filing of this paper, including extension of time fees, to Deposit Account 500417 and please credit any excess fees to such deposit account.

Respectfully submitted,

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Facsimile: (202) 756-8087 **Date: October 24, 2003**

SHEET 1 OF 1

Yes

No

INFORMATION LOSURE ATTY. DOCKET NO. SERIAL NO. 49959-220 09/986,137 CITATION IN AN **APPLICATION APPLICANT** Gilad ALMOGY, et al. FILING DATE **GROUP** (PTO-1449) November 07, 2001 2881 **U.S. PATENT DOCUMENTS EXAMINER'S** Document Number Publication Date Name of Patentee or Applicant of Cited Pages, Columns, Lines, Where Relevant Passages or Relevant INITIALS MM-DD-YYYY Document CITE Number-Kind Code2 (# known) Figures Appear US 5,090,803 02/25/92 Ames et al. US 5,239,178 08/24/93 Demdinger et al. US 4,500,202 02/19/85 Smyth US 3,963,354 06/15/76 Feldman et al. US 5,196,900 03/23/93 Pettersen US 6,108,090 08/22/00 Ishihara US 5,783,833 07/21/98 Sugaya et al. 6,208,411 US 03/27/01 Vaez-Iravani US FOREIGN PATENT DOCUMENTS **EXAMINER'S** Foreign Patent Document Publication Date Name of Patentee or Pages, Columns, Lines Translation Country Code3 -Number 4 -Kind Codes (if known) INITIALS Applicant of Cited Document Where Relevant CITE MM-DD-YYYY Figures Appear NO.

OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)

Europe

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	CITE NO.	published.	age(s), volume-issue number(s), publisher, city and/or country where
		"Quality control and process observation for the n OF MEASUREMENT AND CONTROL; vol. 30, no	nicro assembly process",, Tilo Pfeifer et al, MEASUREMENT, INSTITUTE o. 1, July 2001, pp. 1-18.
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EVALUATED.			

EXAMINER DATE CONSIDERED

12/06/00

09/18/97

09/23/99

10/04/01

EP 1058111 A2

WO 97/34171

WO 99/48041

EP 1138254 A1

^{*}EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

¹ Applicant's unique citation designation number (optional). 2 Applicant is to place a check mark here if English language Translation is attached.